

<b>Notice of References Cited</b>	Application/Control No. 10/042,142	Applicant(s)/Patent Under Reexamination LIN ET AL.	
	Examiner Alicia Baturay	Art Unit 2155	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,674,765 B1	01-2004	Chuah et al.	370/458
*	B	US-6,862,280	03-2005	Bertagna, Drew	370/392
*	C	US-6,862,630 B1	03-2005	Garg et al.	709/250
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	K	US-			
	L	US-			
	M	US-			

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	N					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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